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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/743,305	INA ET AL.	
Examiner	Art Unit	
Mark J. Beauchaine	3653	

SEARCHED			
Class	Subclass	Date	Examiner
194	350,206, 215,216, 217,302	8/24/2005	МЈВ
209	534	8/24/2005	MJB
235	379	8/24/2005	MJB
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST 2.0.1 - USPAT, USPGPUB, JPO, EPO, DERWENT	8/24/2005	MJB
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